TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSV)

2 S J 6 1 0

High Speed Switching, High Current Applications Switching Regulator, DC-DC Converter and Motor Drive Applications

Features

- Low drain-source ON resistance: RDS (ON) = 1.85Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 1.8 \text{ S (typ.)}$
- Low leakage current: $IDSS = -100 \mu A (VDS = -250 V)$
- Enhancement-mode: $V_{th} = -1.5 \sim -3.5 \text{ V}$ ($V_{DS} = 10 \text{ V}$, $I_{D} = 1 \text{ mA}$)

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-250	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	-250	V	
Gate-source voltage		V_{GSS}	±20	V	
Drain current	DC	I _D	-2.0	Α	
	Pulse (t = 1 ms)	I _{DP}	-4.0		
Drain power dissipation (Ta = 25°C) (Note)		P_{D}	20	W	
Single pulse avalanche energy*		E _{AS}	180	mJ	
Avalanche current		I _{AR}	I _{AR} –2.0		
Repetitive avalanche energy**		E _{AR} 2.0		mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

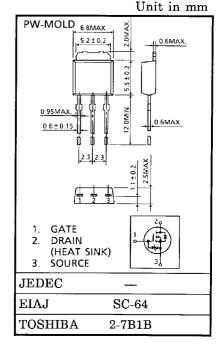
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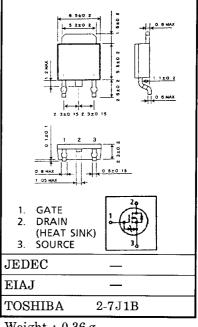
- $V_{DD} = 50 \text{ V}, T_{ch} = 25 ^{\circ}\text{C}, L = 75 \text{ mH}, I_{AR} = -2.0 \text{ A}, R_G = 25 \Omega$
- ** Repetitive rating; pulse width limited by max channel temperature

This transistor is an electrostatic sensitive device.

Please handle with caution.

INDUSTRIAL APPLICATIONS





Weight: 0.36 g

In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..

TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.



Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to case	R _{th (ch-c)}	6.25	°C/W	
Thermal resistance, channel to ambient	R _{th (ch-a)}	125	°C/W	

Electrical Characteristics (Ta = 25°C)

Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Drain cut-off current		I _{DSS}	V _{DS} = -250 V, V _{GS} = 0 V	_	_	-100	μА
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-250	_	_	٧
Gate threshold vo	oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-1.5	_	-3.5	V
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = -10 \text{ V}, I_D = -1.0 \text{ A}$		1.85	2.55	Ω
Forward transfer	admittance	Y _{fs}	$V_{DS} = -10 \text{ V}, I_D = -1.0 \text{ A}$	0.5	1.8	_	S
Input capacitance		C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	1	381	_	pF
Reverse transfer capacitance		C _{rss}			52		
Output capacitance		C _{oss}		_	157	_	
Switching time	Rise time	t _r	$\begin{array}{c c} 10 \text{ V} & I_D = 1.0 \text{ A} & V_{OUT} \\ \hline V_{GS} & & & \\ \hline 50 \Omega & & \\ \hline \end{array} \\ \begin{array}{c} R_L = 100 \Omega \\ \hline \end{array} \\ \begin{array}{c} V_{IN} : t_r, t_f < 5 \text{ ns} \\ \hline \\ Duty \leq 1\%, t_W = 10 \mu\text{s} \end{array}$		5	_	- ns
	Turn-on time	t _{on}		_	20	_	
	Fall time	t _f		_	6	_	
	Turn-off time	t _{off}		_	36	_	
Total gate charge		Qg	$V_{DD} \simeq -200 \text{ V}, V_{GS} = -10 \text{ V},$	_	24		nC
Gate-source charge		Q _{gs}		_	10	_	
Gate-drain charge		Q _{gd}	$I_D = -2.0 \text{ A}$	_	13	—	

Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

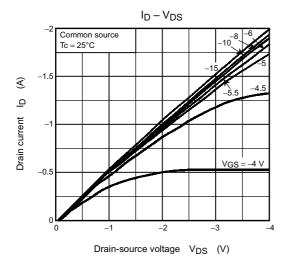
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current	I _{DR}	_	_	_	-2.0	Α
Pulse drain reverse current	I _{DRP}	_	_	_	-4.0	Α
Diode forward voltage	V _{DSF}	$I_{DR} = -2.0 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	2.0	V
Reverse recovery time	t _{rr}	$I_{DR} = -2.0 \text{ A}, V_{GS} = 0 \text{ V},$	_	120	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} /dt = 100 A/μs	_	540	_	nC

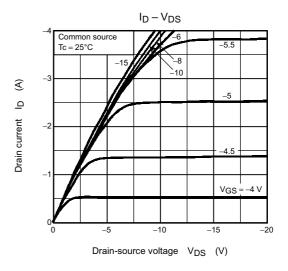
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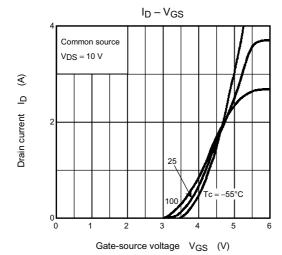
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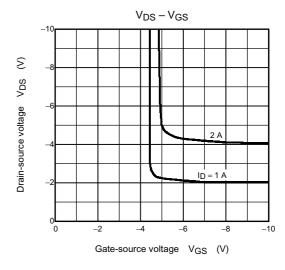
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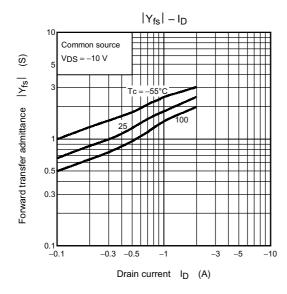
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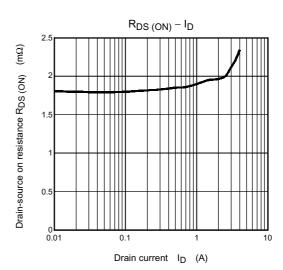


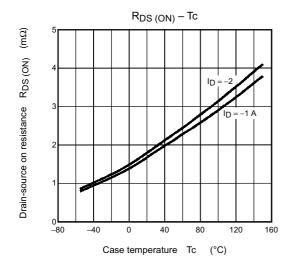


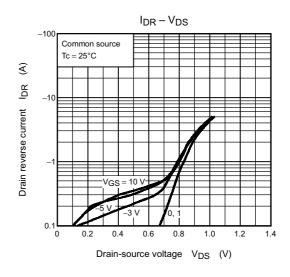


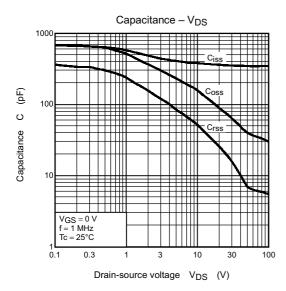


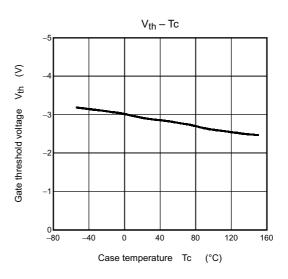


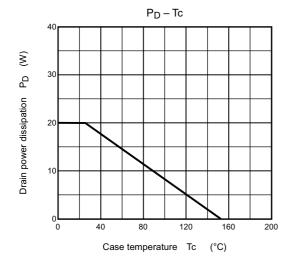


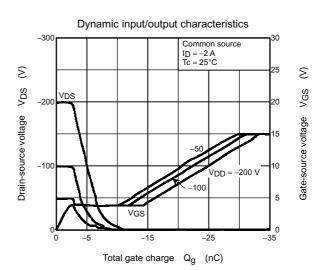


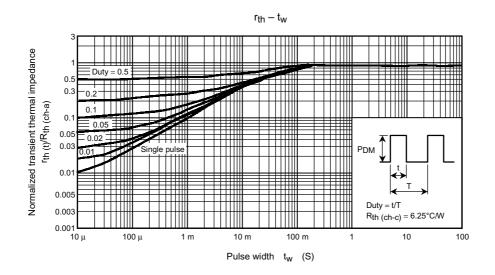


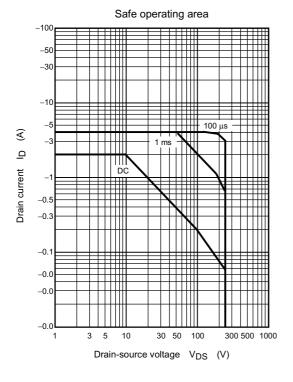


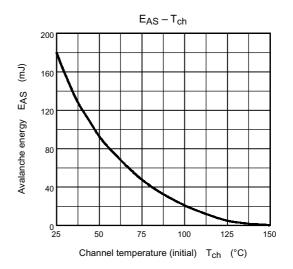


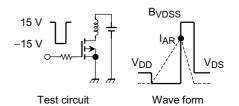












$$\begin{aligned} & \text{Peak I}_{AR} = -2 \text{ A, R}_G = 25 \ \Omega \\ & \text{V}_{DD} = -50 \text{ V, L} = 75 \text{ mH} \end{aligned} \quad \text{EAS} = \frac{1}{2} \cdot \text{L} \cdot \text{I}^2 \cdot \left(\frac{\text{BVDSS}}{\text{BVDSS} - \text{VDD}} \right)$$